MOSFET – N-Channel, POWERTRENCH[®]

60 V, 77 A, 4.1 mΩ

FDPF041N06BL1-F154

Description

This N-Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Features

- $R_{DS(on)} = 3.5 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 77 \text{ A}$
- Low FOM R_{DS(on)}*Q_G
- Low Reverse Recovery Charge, Q_{rr}
- Soft Reverse Recovery Body Diode
- Enables Highly Efficiency in Synchronous Rectification
- Fast Switching Speed
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

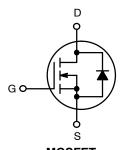
- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Renewable System



ON Semiconductor®

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V _{DSS}	R _{DS(ON)} MAX	I _D MAX
60 V	4.1 m Ω @ 10 V	77 A

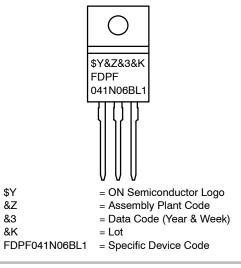






TO-220F Ultra Narrow Lead CASE 221BN

MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise noted)

Symbol	Parameter		Value	Unit
V _{DSS}	Drain to Source Voltage		60	V
V _{GSS}	Gate to Source Voltage		±20	V
I _D Dra	Drain Current	– Continuous (T _C = 25°C, Silicon Limited)	77	А
		– Continuous (T _C = 100°C, Silicon Limited)	55	
I _{DM}	Drain Current	– Pulsed (Note 1)	308	А
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		365	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.0	V/ns
P _D Power Dissipation	$(T_{\rm C}=25^{\circ}{\rm C})$	44.1	W	
		– Derate Above 25°C	0.29	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		–55 to +175	°C
ΤL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 3 mH, I_{AS} = 15,6 A, starting T_J = 25°C.

3. $I_{SD} \le 100$ Å, di/dt ≤ 200 Å/µs, $V_{DD} \le BV_{DSS}$, starting $T_J = 25^{\circ}C$.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
R_{\thetaJC}	Thermal Resistance, Junction to Case, Max.	3.4	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Quantity
FDPF041N06BL1-F154	FDPF041N06BL1	TO-220F (Pb-Free)	50 Units / Tube

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARACT	ERISTICS	•	-			
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	60	-	-	V
$\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$	-	0.03	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA
I _{GSS}	Gate to Body Leakage Current	V_{GS} = ± 20 V, V_{DS} = 0 V	-	-	±100	nA
N CHARACTE	RISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS},\ I_{D}=250\ \mu A$	2	-	4	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 77 A	-	3.5	4.1	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 77 A	-	125	_	S
	RACTERISTICS					
C _{iss}	Input Capacitance	V_{DS} = 30 V, V_{GS} = 0 V, f = 1 MHz	-	4280	5690	pF
Coss	Output Capacitance		-	1050	1400	pF
C _{rss}	Reverse Transfer Capacitance		-	23	_	pF
C _{oss(er)}	Energy Related Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	-	1787	-	pF
Q _{g(tot)}	Total Gate Charge at 10 V	V _{DS} = 30 V, I _D = 100 A, V _{GS} = 10 V (Note 4)	-	53	69	nC
Q _{gs}	Gate to Source Gate Charge		-	23	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	8	-	nC
V _{plateau}	Gate Plateau Voltage		-	5.7	-	V
Q _{sync}	Total Gate Charge Sync.	V _{DS} = 0 V, I _D = 50 A	-	48.6	-	nC
Q _{oss}	Output Charge	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	63.8	_	nC
WITCHING CH	IARACTERISTICS	•				
t _{d(on)}	Turn-On Delay Time	V _{DD} = 30 V, I _D = 100 A,	-	29	68	ns
t _r	Turn-On Rise Time	V _{GS} = 10 V, R _{GEN} = 4.7 Ω (Note 4)	-	22	54	ns
t _{d(off)}	Turn-Off Delay Time		-	38	86	ns
t _f	Turn-Off Fall Time		-	11	32	ns
ESR	Equivalent Series Resistance (G-S)	f = 1 MHz	-	0,8	-	Ω
RAIN-SOURC	E DIODE CHARACTERISTICS	•	-			
۱ _S	Maximum Continuous Source to Drain Diode Forward Current		-	-	77	Α
I _{SM}	Maximum Pulsed Source to Drain Diode Forward Current		-	-	308	Α
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{SD} = 77 A$	-	-	1.25	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 100 A,	-	65	-	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/µs		63	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS

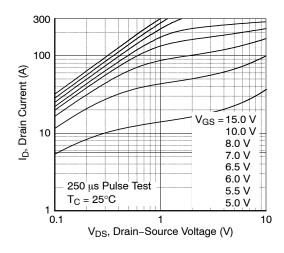
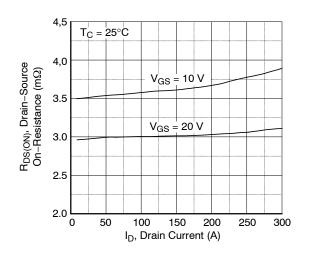
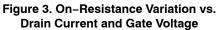


Figure 1. On-Region Characteristics





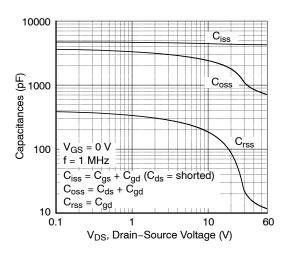


Figure 5. Capacitance Characteristics

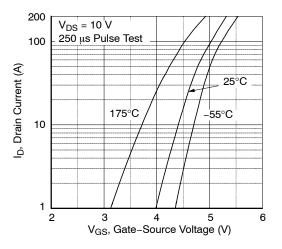


Figure 2. Transfer Characteristics

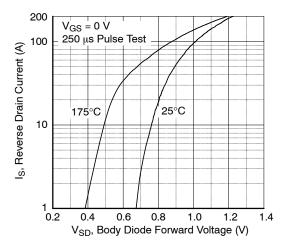


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

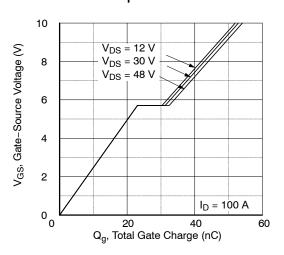
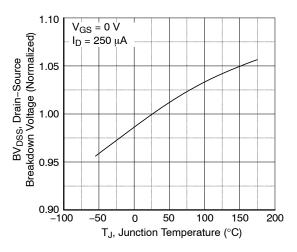
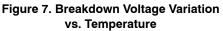


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)





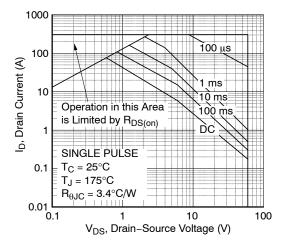


Figure 9. Maximum Safe Operating Area vs. Case Temperature

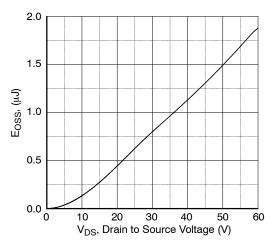


Figure 11. E_{OSS} vs. Drain to Source Voltage

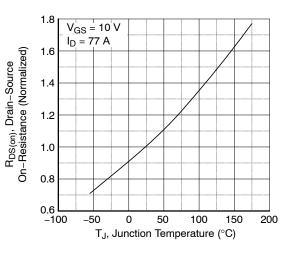


Figure 8. On–Resistance Variation vs. Temperature

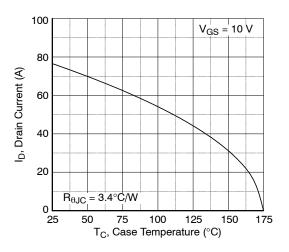
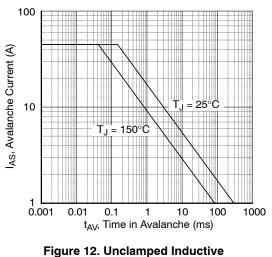


Figure 10. Maximum Drain Current



Switching Capability

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

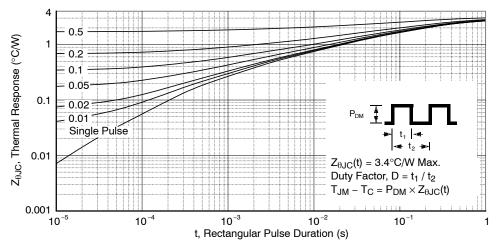


Figure 13. Transient Thermal Response Curve

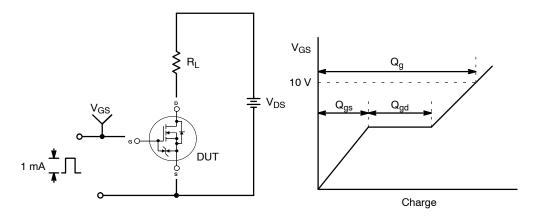


Figure 14. Gate Charge Test Circuit & Waveform

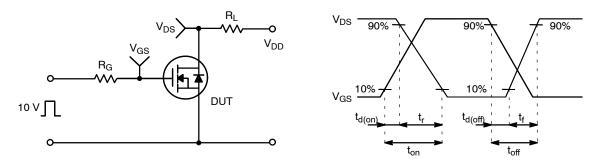


Figure 15. Resistive Switching Test Circuit & Waveforms

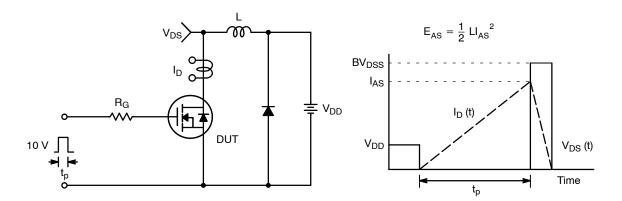


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

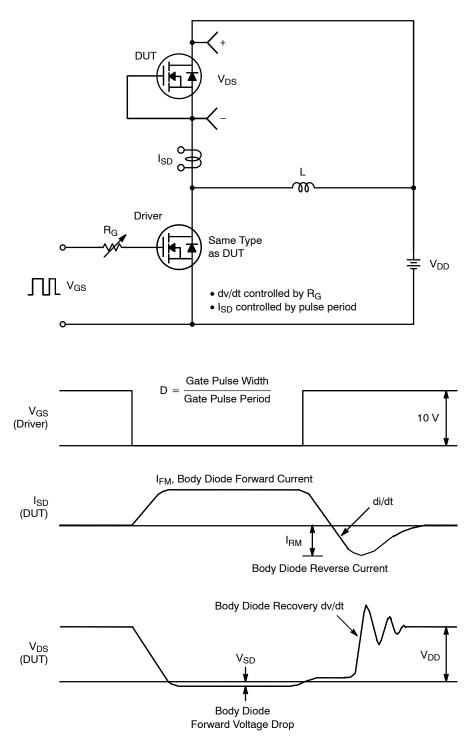


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

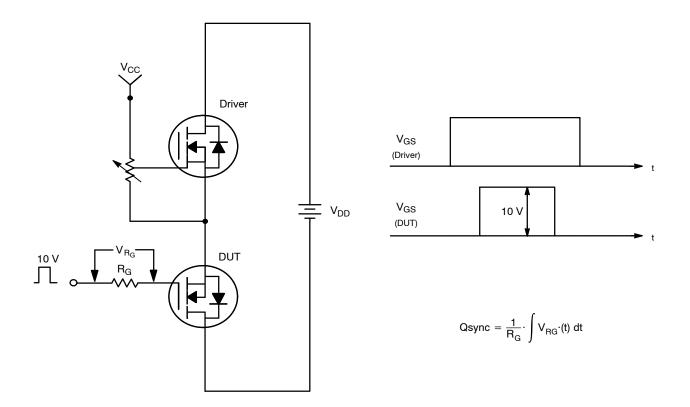


Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms

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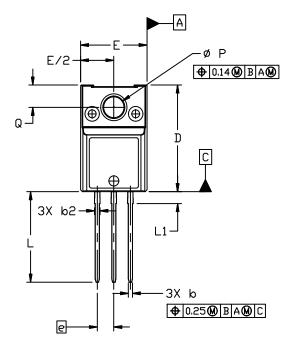
TO-220 FULLPACK, 3-LEAD (ULTRA NARROW LEAD)

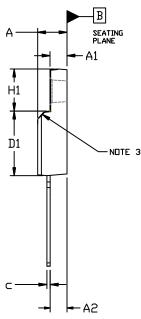
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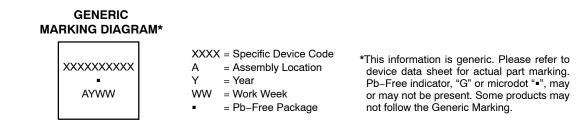
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- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. CONTOUR UNCONTROLLED IN THIS AREA.
- 4. DIMENSIONS EXCLUDE BURRS, MOLD FLASH, AND TIE BAR PROTRUSIONS.





	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
А	4.60	4.70	4.80	
A1	2.50	2.60	2.70	
A2	2.47	2.57	2.67	
σ	0.56	0.63	0.69	
b2			0.90	
U	0.46	0.53	0.59	
D	15.80	16.00	16.20	
D1	9.58	9.68	9.78	
Е	10.00	10.20	10.40	
e	2.54 BSC			
H1	6.32 REF			
Г	13.45	13.60	13.75	
L1	1.70	1.80	1.90	
Ρ	3.00	3.10	3.20	
ß	3.25	3.35	3,45	



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